

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/597,288	CHIDAMBARRAO ET AL.	
Examiner		Art Unit		Page 1 of 1
KENNETH HAMLIN		2893		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,414,289	05-1995	Fitch et al.	257/329
*	B	US-6,680,508	01-2004	Rudeck, Paul	257/316
*	C	US-6,238,976	05-2001	Noble et al.	438/259
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Sub-50 nm P-Channel FinFET" Huang et al. IEEE Transactions on Electron Devices. Vol. 48, No. 5, May 2001.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.